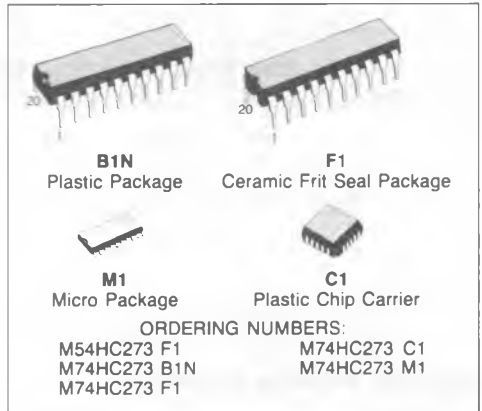


OCTAL D-TYPE FLIP FLOP WITH CLEAR

- **HIGH SPEED**
 $f_{MAX} = 48 \text{ MHz (TYP.) at } V_{CC} = 5 \text{ V}$
- **LOW POWER DISSIPATION**
 $I_{CC} = 4 \mu\text{A (MAX.) at } T_A = 25^\circ\text{C}$
- **HIGH NOISE IMMUNITY**
 $V_{NIH} = V_{NIL} = 28\% V_{CC} \text{ (MIN.)}$
- **OUTPUT DRIVE CAPABILITY**
 10 LSTTL LOADS
- **SYMMETRICAL OUTPUT IMPEDANCE**
 $|I_{OH}| = I_{OL} = 4 \text{ mA (MIN.)}$
- **BALANCED PROPAGATION DELAYS**
 $t_{PLH} = t_{PHL}$
- **WIDE OPERATING VOLTAGE RANGE**
 $V_{CC} \text{ (OPR)} = 2 \text{ V to } 6 \text{ V}$
- **PIN AND FUNCTION COMPATIBLE**
 WITH 54/74LS273



DESCRIPTION




The M54/74HC273 is a high speed CMOS OCTAL D-TYPE FLIP FLOP WITH CLEAR fabricated in silicon gate C²MOS technology. It has the same high speed performance of LSTTL combined with true CMOS low power consumption.

Information signals applied to D inputs are transferred to the Q outputs on the positive-going edge of the clock pulse.

When the CLEAR input is held low, the Q output are in the low logic level independent of the other inputs.

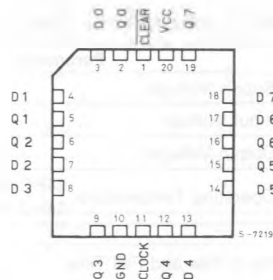
All inputs are equipped with protection circuits against static discharge and transient excess voltage.

TRUTH TABLE

INPUTS			OUTPUT	FUNCTION
CLEAR	D	CLOCK	Q	
L	X	X	L	CLEAR
H	L		L	
H	H		H	
H	X		Q _n	NO CHANGE

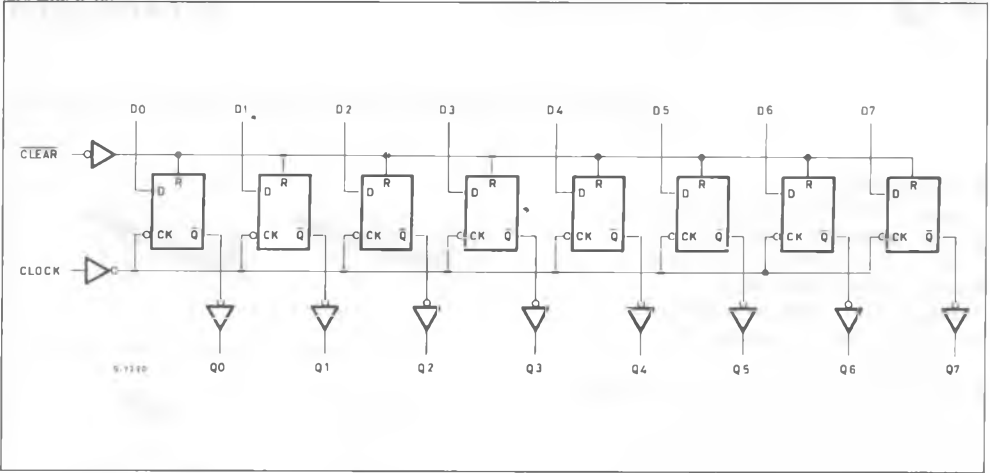
X: DON'T CARE

PIN CONNECTIONS (top view)



NC =
No Internal
Connection

LOGIC DIAGRAM



ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V_{CC}	Supply Voltage	-0.5 to 7	V
V_I	DC Input Voltage	-0.5 to $V_{CC} + 0.5$	V
V_O	DC Output Voltage	-0.5 to $V_{CC} + 0.5$	V
I_{IK}	DC Input Diode Current	± 20	mA
I_{OK}	DC Output Diode Current	± 20	mA
I_O	DC Output Source Sink Current Per Output Pin	± 25	mA
I_{CC} or I_{GND}	DC V_{CC} or Ground Current	± 50	mA
PD	Power Dissipation	500 (*)	mW
T_{stg}	Storage Temperature	-65 to 150	$^{\circ}C$

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these condition is not implied.

(*) 500 mW: \cong 65 $^{\circ}C$ derate to 300 mW by 10 mW/ $^{\circ}C$: 65 $^{\circ}C$ to 85 $^{\circ}C$.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Value	Unit
V_{CC}	Supply Voltage	2 to 6	V
V_I	Input Voltage	0 to V_{CC}	V
V_O	Output Voltage	0 to V_{CC}	V
T_A	Operating Temperature 74HC Series 54HC Series	-40 to 85 -55 to 125	$^{\circ}C$
t_r, t_f	Input Rise and Fall Time	$V_{CC} \begin{cases} 2 \text{ V} & 0 \text{ to } 1000 \\ 4.5 \text{ V} & 0 \text{ to } 500 \\ 6 \text{ V} & 0 \text{ to } 400 \end{cases}$	ns

DC SPECIFICATIONS

Symbol	Parameter	V _{CC}	Test Condition	T _A = 25°C 54HC and 74HC			- 40 to 85°C 74HC		- 55 to 125°C 54HC		Unit		
				Min.	Typ.	Max.	Min.	Max.	Min.	Max.			
V _{IH}	High Level Input Voltage	2.0 4.5 6.0		1.5 3.15 4.2	— — —	— — —	1.5 3.15 4.2	— — —	1.5 3.15 4.2	— — —	V		
V _{IL}	Low Level Input Voltage	2.0 4.5 6.0		— — —	— — —	0.5 1.35 1.8	— — —	0.5 1.35 1.8	— — —	0.5 1.35 1.8	V		
V _{OH}	High Level Output Voltage	2.0 4.5 6.0 4.5 6.0	V _I	I _O	1.9	2.0	—	1.9	—	1.9	—	V	
			V _{IH} or V _{IL}	- 20 μA	4.4 5.9	4.5 6.0	— —	4.4 5.9	— —	4.4 5.9	— —		
				- 4.0 mA	4.18	4.31	—	4.13	—	4.10	—		
				- 5.2 mA	5.68	5.8	—	5.63	—	5.60	—		
V _{OL}	Low Level Output Voltage	2.0 4.5 6.0 4.5 6.0	V _{IH} or V _{IL}	20 μA	—	0.0	0.1	—	0.1	—	0.1	V	
					—	0.0	0.1	—	0.1	—	0.1		
					4.0 mA	—	0.17	0.26	—	0.33	—		0.40
					5.2 mA	—	0.18	0.26	—	0.33	—		0.40
I _I	Input Leakage Current	6.0	V _I = V _{CC} or GND	—	—	± 0.1	—	± 1.0	—	± 1.0	μA		
I _{CC}	Quiescent Supply Current	6.0	V _I = V _{CC} or GND	—	—	4	—	40	—	80	μA		

AC ELECTRICAL CHARACTERISTICS (V_{CC} = 5V, T_A = 25°C, C_L = 15pF, Input t_r = t_f = 6ns)

Symbol	Parameter	54HC and 74HC			Unit
		Min.	Typ.	Max.	
t _{TLH} t _{THL}	Output Transition Time	—	4	8	ns
t _{PLH} t _{PHL}	Propagation Delay Time (CLOCK-Q)	—	20	31	ns
t _{PHL}	Propagation Delay Time (CLEAR-Q)	—	19	30	ns
f _{MAX}	Maximum Clock Frequency	30	48	—	MHz

AC ELECTRICAL CHARACTERISTICS ($C_L = 50\text{pF}$, Input $t_r = t_f = 6\text{ns}$)

Symbol	Parameter	V_{CC}	Test Condition	$T_A = 25^\circ\text{C}$ 54HC and 74HC			- 40 to 85°C 74HC		- 55 to 125°C 54HC		Unit
				Min.	Typ.	Max.	Min.	Max.	Min.	Max.	
t_{TLH} t_{THL}	Output Transition Time	2.0		—	30	75	—	95	—	110	ns
		4.5		—	9	15	—	19	—	22	
		6.0		—	8	13	—	16	—	19	
t_{PLH} t_{PHL}	Propagation Delay Time (CLOCK - Q)	2.0		—	92	180	—	225	—	270	ns
		4.5		—	25	36	—	45	—	54	
		6.0		—	22	31	—	38	—	46	
t_{PLH}	Propagation Delay Time (CLEAR-Q)	2.0		—	92	175	—	220	—	265	ns
		4.5		—	25	35	—	44	—	53	
		6.0		—	22	30	—	37	—	45	
f_{MAX}	Maximum Clock Frequency	2.0		5.4	11	—	4.4	—	3.6	—	MHz
		4.5		27	44	—	22	—	18	—	
		6.0		32	52	—	26	—	21	—	
$t_{W(L)}$ $t_{W(H)}$	Minimum Pulse Width (CLOCK)	2.0		—	30	75	—	95	—	110	ns
		4.5		—	8	15	—	19	—	22	
		6.0		—	7	13	—	16	—	19	
$t_{W(L)}$	Minimum Pulse Width (CLEAR)	2.0		—	30	75	—	95	—	110	ns
		4.5		—	8	15	—	19	—	22	
		6.0		—	7	13	—	16	—	19	
t_s	Minimum Set-up Time	2.0		—	30	75	—	95	—	110	ns
		4.5		—	8	15	—	19	—	22	
		6.0		—	6	13	—	16	—	19	
t_h	Minimum Hold Time	2.0		—	—	0	—	0	—	0	ns
		4.5		—	—	0	—	0	—	0	
		6.0		—	—	0	—	0	—	0	
t_{REM}	Minimum Removal Time CLEAR	2.0		—	18	75	—	95	—	110	ns
		4.5		—	5	15	—	19	—	22	
		6.0		—	4	13	—	16	—	19	
C_{IN}	Input Capacitance			—	5	10	—	10	—	10	pF
$C_{PD} (*)$	Power Dissipation Capacitance			—	53	—	—	—	—	—	pF

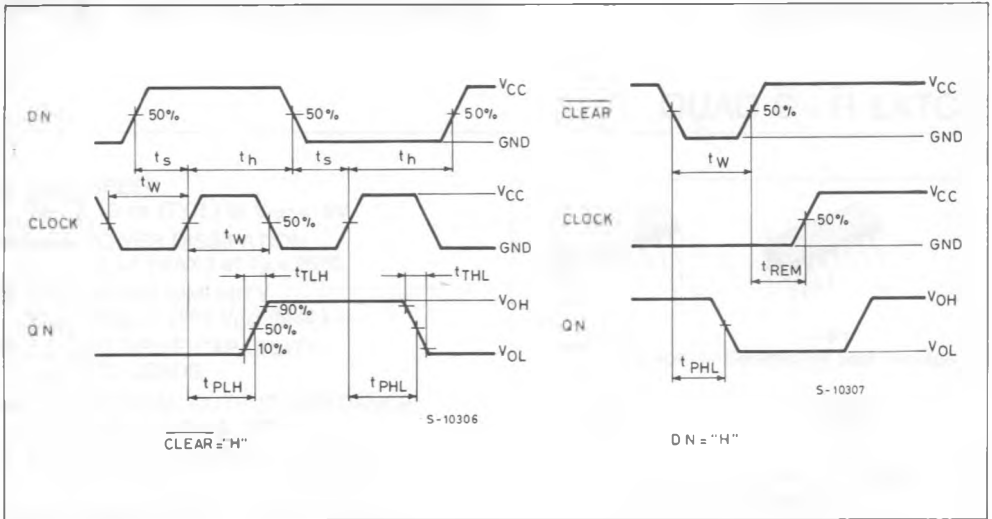
Note (*) C_{PD} is defined as the value of the IC's internal equivalent capacitance which is calculated from the operating current consumption without load. (Refer to Test Circuit)

Average operating current is: $I_{CC(oper)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8$ (per FF)

And the total C_{PD} when n pcs Flip Flop operate can be gained by the following equation.

$$C_{PD}(\text{total}) = 38 + 15 \cdot n$$

SWITCHING CHARACTERISTICS TEST WAVEFORM



TEST CIRCUIT I_{CC} (Opr.)

